


**PALM INTRANET**

 Day : Tuesday  
 Date: 3/6/2007  
 Time: 08:14:54
**Inventor Name Search Result**

Your Search was:

Last Name = GERLACH

First Name = ROBERT

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>10804463</u>	Not Issued	30	03/18/2004	LED lighting arrays, fixtures and systems and method for determining human color perception	GERLACH, ROBERT
<u>60175699</u> <i>Pro Aband</i>	Not Issued	159	01/12/2000	GAS INJECTOR CRUCIBLE ALLOWING SHIPPING OF MATERIALS IN-SITU	GERLACH, ROBERT
<u>60455896</u> <i>Pro Aband</i>	Not Issued	159	03/18/2003	LED lighting arrays, fixtures and systems and method for determining human color perception	GERLACH, ROBERT
<u>60042884</u> <i>Pro-Aband</i>	Not Issued	159	03/31/1997	CINCH TYPE FISHING YOYO AND WATER FOWL DECOY WEIGHT RETRIEVING SYSTEM	GERLACH, ROBERT D.
<u>60177518</u> <i>Pro-Aband</i>	Not Issued	159	01/21/2000	Shaped and low density focused ion beams	GERLACH, ROBERT L
<u>09765806</u> <i>Patent</i>	<u>6949756</u>	150	01/19/2001	SHAPED AND LOW DENSITY FOCUSED ION BEAMS	GERLACH, ROBERT L.
<u>09780876</u> <i>Appellate</i>	Not Issued	120	02/08/2001	Through-the-lens-collection of secondary particles for a focused ion beam system	GERLACH, ROBERT L.
<u>09781125</u> <i>Pat</i>	<u>6797969</u>	150	02/08/2001	MULTI-COLUMN FIB FOR NANOFABRICATION APPLICATIONS	GERLACH, ROBERT L.
<u>09840558</u> <i>Pat</i>	<u>6946654</u>	150	04/23/2001	COLLECTION OF SECONDARY ELECTRONS THROUGH THE OBJECTIVE LENS OF A SCANNING ELECTRON MICROSCOPE	GERLACH, ROBERT L.
<u>09859295</u> <i>Pat</i>	<u>6683320</u>	150	05/16/2001	THROUGH-THE-LENS NEUTRALIZATION FOR CHARGED PARTICLE BEAM SYSTEM	GERLACH, ROBERT L.

<u>09982110</u>	<u>6710338</u>	150 <i>Pat</i>	10/17/2001	FOCUSED ION BEAM SYSTEM	GERLACH, ROBERT L.
<u>10081247</u>	<u>6797953</u>	150 <i>Pat</i>	02/22/2002	ELECTRON BEAM SYSTEM USING MULTIPLE ELECTRON BEAMS	GERLACH, ROBERT L.
<u>10606930</u>	<u>7009187</u>	150 <i>Pat</i>	06/26/2003	PARTICLE DETECTOR SUITABLE FOR DETECTING IONS AND ELECTRONS	GERLACH, ROBERT L.
<u>10635228</u>	<u>6900447</u>	150 <i>Pat</i>	08/06/2003	FOCUSED ION BEAM SYSTEM WITH COAXIAL SCANNING ELECTRON MICROSCOPE	GERLACH, ROBERT L.
<u>10688810</u>	<u>6977386</u>	150 <i>Pat</i>	10/17/2003	ANGULAR APERTURE SHAPED BEAM SYSTEM AND METHOD	GERLACH, ROBERT L.
<u>60181248</u>	Not Issued	159 <i>Pat</i>	02/09/2000	Multi-column fib for nanofabrication applications	GERLACH, ROBERT L.
<u>60199280</u>	Not Issued	159 <i>Pat</i>	04/24/2000	Method and apparatus for collection of secondary electrons through the objective lens of a scanning electron microscope	GERLACH, ROBERT L.
<u>60205605</u>	Not Issued	159 <i>Pat</i>	05/18/2000	Through-the-lens sample neutralizing electron beam for focused ion beam system	GERLACH, ROBERT L.
<u>60241536</u>	Not Issued	159 <i>Pat</i>	10/18/2000	FOCUSED ION BEAM SYSTEM	GERLACH, ROBERT L.
<u>60270799</u>	Not Issued	159 <i>Pat</i>	02/23/2001	Multiple column electron beam system	GERLACH, ROBERT L.
<u>60317584</u>	Not Issued	159 <i>Pat</i>	09/06/2001	Two dimensional array multiple column FIB design	GERLACH, ROBERT L.
<u>60401718</u>	Not Issued	159 <i>Pat</i>	08/07/2002	Coaxial FIB-SEM column	GERLACH, ROBERT L.
<u>06128932</u>	<u>4296323</u>	150 <i>Pat</i>	03/10/1980	SECONDARY EMISSION MASS SPECTROMETER MECHANISM TO BE USED WITH OTHER INSTRUMENTATION	GERLACH, ROBERT L.
<u>06176735</u>	<u>4345152</u>	150 <i>Pat</i>	08/11/1980	MAGNETIC LENS	GERLACH, ROBERT L.
<u>06288439</u>	<u>4412771</u>	250	07/30/1981	SAMPLE TRANSPORT SYSTEM	GERLACH, ROBERT L.
<u>06404932</u>	Not Issued	161 <i>Aband</i>	08/02/1982	ALIGNMENT ASSEMBLY	GERLACH, ROBERT L.
<u>06510003</u>	Not Issued	161 <i>Aband</i>	07/01/1983	APPARATUS USEFUL IN SURFACE ANALYSIS	GERLACH, ROBERT L.

*Exp. Pat.*

<u>06641110</u>	Not Issued	168 <i>Abroad</i>	08/15/1984	ION GUN ASSEMBLY	GERLACH, ROBERT L.
<u>06664195</u>	Not Issued	166 <i>Abroad</i>	10/24/1984	VACUUM-COMPATIBLE AIR-COOLED PLASMA DEVICE	GERLACH, ROBERT L.
<u>06833575</u>	4659899	150 <i>Pat</i>	02/26/1986	VACUUM-COMPATIBLE AIR-COOLED PLASMA DEVICE	GERLACH, ROBERT L.
<u>07058437</u>	4810880	150 <i>Pat</i>	06/05/1987	DIRECT IMAGING MONOCHROMATIC ELECTRON MICROSCOPE	GERLACH, ROBERT L.
<u>07064283</u>	4806754	150 <i>Pat</i>	06/19/1987	HIGH LUMINOSITY SPHERICAL ANALYZER FOR CHARGED PARTICLES	GERLACH, ROBERT L.
<u>07268440</u>	4882487	150 <i>Pat</i>	11/08/1988	DIRECT IMAGING MONOCHROMATIC ELECTRON MICROSCOPE	GERLACH, ROBERT L.
<u>07565289</u>	5032724	150 <i>Pat</i>	08/09/1990	MULTICHANNEL CHARGED-PARTICLE ANALYZER	GERLACH, ROBERT L.
<u>07717075</u>	Not Issued	166 <i>Abroad</i>	06/18/1991	PRECISION ELECTROSTATIC LENS SYSTEM AND METHOD OF MANUFACTURE	GERLACH, ROBERT L.
<u>07982242</u>	5241182	150 <i>Pat</i>	11/25/1992	PRECISION ELECTROSTATIC LENS SYSTEM AND METHOD OF MANUFACTURE	GERLACH, ROBERT L.
<u>09350718</u>	6414307	150 <i>Pat</i>	07/09/1999	METHOD AND APPARATUS FOR ENHANCING YIELD OF SECONDARY IONS	GERLACH, ROBERT L.
<u>10154020</u>	6949240	150 <i>Pat</i>	05/23/2002	TOOTH WHITENING PRODUCTS	GERLACH, ROBERT WOODROW
<u>10659100</u>	Not Issued	71 <i>Reexam</i>	09/10/2003	Tooth whitening strips	GERLACH, ROBERT WOODROW
<u>11199976</u>	Not Issued	41 <i>Now First</i>	08/09/2005	Tooth whitening products	GERLACH, ROBERT WOODROW
<u>60833281</u>	Not Issued	20 <i>NYD</i>	07/25/2006	Methods and products for analyzing gingival tissues	GERLACH, ROBERT WOODROW

Inventor Search Completed: No Records to Display.

Search Another: Inventor	Last Name	First Name	Search
	<input type="text" value="gerlach"/>	<input type="text" value="robert"/>	

To go back use Back button on your browser toolbar.

Back to [PALM](#) | [ASSIGNMENT](#) | [OASIS](#) | Home page